

FDP2670/FDB2670

200V N-Channel PowerTrench[®] MOSFET

General Description

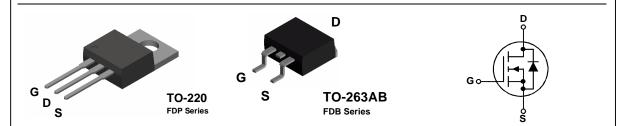
This N-Channel MOSFET has been designed specifically for switching on the primary side in the isolated DC/DC converter application. Any application requiring a 200V MOSFETs with low on-resistance and fast switching will benefit.

These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $RDS_{(ON)}$ specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

Features

- 19 A, 200 V. $R_{DS(ON)}$ = 130 m Ω @ V_{GS} = 10 V
- Low gate charge (27 nC typical)
- Fast switching speed
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability



Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		200	V
V _{GSS}	Gate-Source Voltage		± 20	V
I _D	Drain Current – Continuous	(Note 1)	19	А
	- Pulsed	(Note 1)	40	А
PD	Total Power Dissipation @ T _c = 25°C	;	93	W
	Derate	above 25°C	0.63	W°/C
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	3.2	V/ns
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-65 to +175	°C

Thermal Characteristics

R _{θJC}	Thermal Resistance, Junction-to-Case	1.6	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	62.5	°C/W

Package Marking and Ordering Information

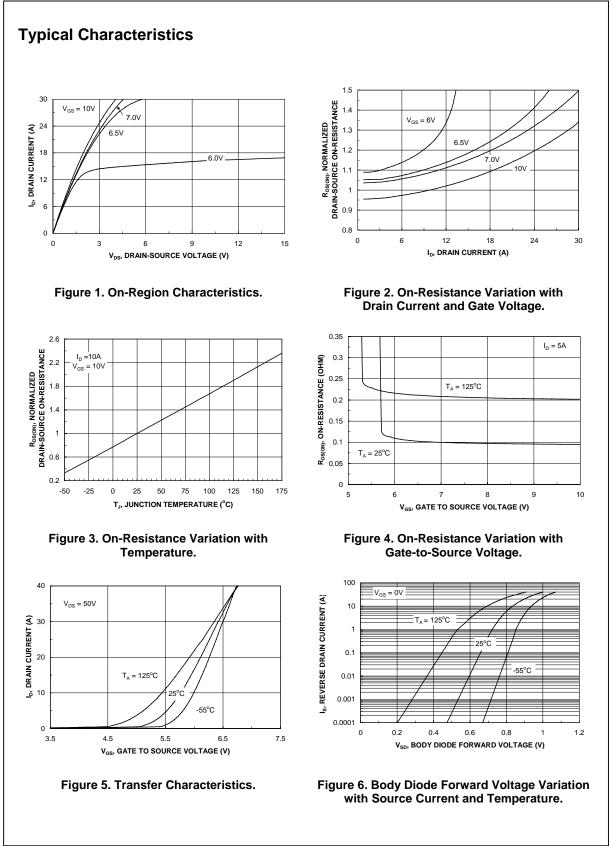
Device Marking	Device	Reel Size	Tape width	Quantity
FDB2670	FDB2670	13"	24mm	800 units
FDP2670	FDP2670	Tube	n/a	45 units

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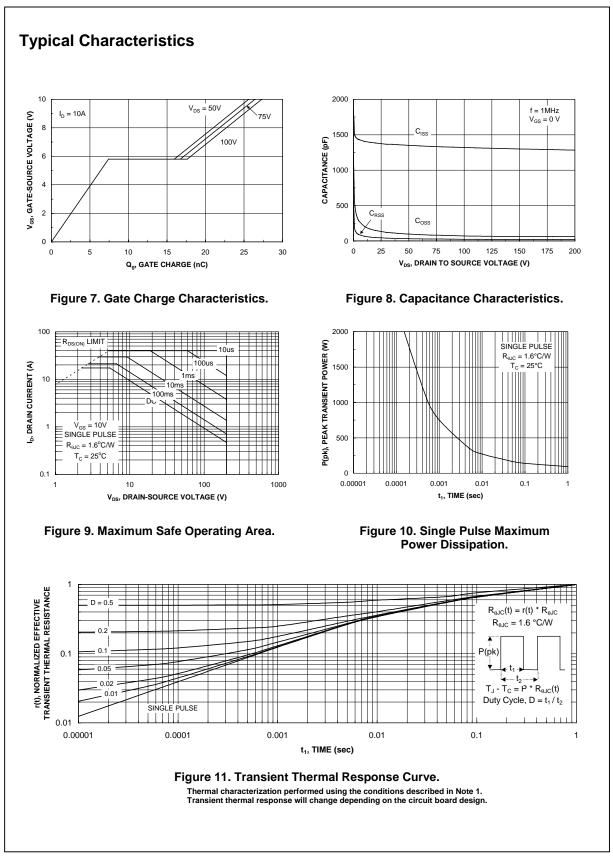
Symbol	Parameter	Test Conditions	Min	Тур	Мах	Units
Drain-So	burce Avalanche Ratings (Note	1)				1
N _{DSS}	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 100 \text{ V}, \qquad I_D = 10 \text{ A}$			375	mJ
AR	Maximum Drain-Source Avalanche Current				10	A
Off Cha	acteristics		-			
3V _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	200			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu A$, Referenced to $25^{\circ}C$		241		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = 160 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
GSSF	Gate-Body Leakage, Forward	$V_{GS} = 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
GSSR	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V} \qquad V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2	4	4.5	V
<u>ΔVGS(th)</u> ΔTJ	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, Referenced to 25°C		-9		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, \qquad I_D = 10 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}, T_J = 125^{\circ}\text{C}$		98 205	130 285	mΩ
D(on)	On-State Drain Current	$V_{GS} = 10 \text{ V}, \qquad V_{DS} = 10 \text{ V}$	20			А
JFS	Forward Transconductance	$V_{DS} = 10 \text{ V}, \qquad I_D = 10 \text{ A}$		24		S
Dvnami	c Characteristics		•	•		
Ciss	Input Capacitance	$V_{DS} = 100 V$, $V_{GS} = 0 V$,		1320		pF
Coss	Output Capacitance	f = 1.0 MHz		71		pF
Crss	Reverse Transfer Capacitance			24		pF
Switchir	ng Characteristics (Note 2)			•		
d(on)	Turn–On Delay Time	$V_{DD} = 100 V$, $I_D = 1 A$,		14	25	ns
r	Turn–On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		5	10	ns
d(off)	Turn–Off Delay Time			26	41	ns
f	Turn–Off Fall Time			23	37	ns
ζ _g	Total Gate Charge			27	38	nC
Q _{gs}	Gate-Source Charge			7		nC
2 _{gd}	Gate-Drain Charge			10		nC
	ource Diode Characteristics	and Maximum Ratings	•			
s	Maximum Continuous Drain–Source				19	А
/ _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = 10 A$ (Note 2)		0.8	1.3	V

3. $I_{SD} \leq$ 3A, di/dt \leq 100A/µs, $V_{DD} \leq BV_{DSS}, \; Starting \; T_J$ = 25°C

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